

<b>Notice of References Cited</b>	Application/Control No. 10/617,688	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner Marie R. Yamnitzky	Art Unit 1774	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,541,129 B1	04-2003	Kawamura et al.	428/690
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	EP 0 666 298 A2	08-1995	Europe	----	----
	O	EP 1 029 909 A1	08-2000	Europe	----	----
	P					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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